

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/593,580	IWATSUBO ET AL.	
Examiner		Art Unit		Page 1 of 3
J M. SAINT SURIN		2856		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,058,434	10-1991	Zaschel, Jorg	73/659
*	B	US-6,763,312	07-2004	Judd, John E	702/56
*	C	US-7,006,953	02-2006	Takemura et al.	703/2
*	D	US-7,305,330	12-2007	Urakami et al.	703/6
*	E	US-3,705,516	12-1972	Reis, James John	73/659
*	F	US-2005/0246150	11-2005	Shiromaru et al.	703/007
*	G	US-7,241,053	07-2007	Sato et al.	384/448
*	H	US-6,926,445	08-2005	Sato et al.	384/448
*	I	US-6,763,312	07-2004	Judd, John E	702/56
*	J	US-6,711,952	03-2004	Leamy et al.	73/579
*	K	US-6,636,813	10-2003	Isobe et al.	702/34
*	L	US-5,477,730	12-1995	Carter, Duncan L.	73/609
*	M	US-5,042,295	08-1991	Seeley, Robert E.	73/112.03

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/593,580	IWATSUBO ET AL.	
Examiner		Art Unit		Page 2 of 3
J M. SAINT SURIN		2856		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,694,285	02-2004	Choe et al.	702/182
*	B	US-5,109,700	05-1992	Hicho, Michael D.	73/660
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/593,580	IWATSUBO ET AL.	
Examiner		Art Unit	2856	Page 3 of 3
J M. SAINT SURIN				

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.